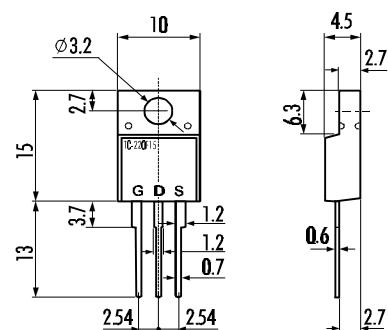


**> Features**

- High Speed Switching
- Low On-Resistance
- No Secondary Breakdown
- Low Driving Power
- High Voltage
- $V_{GS} = \pm 30V$  Guarantee
- Repetitive Avalanche Rated

**> Applications**

- Switching Regulators
- UPS
- DC-DC converters
- General Purpose Power Amplifier

**> Outline Drawing**
**TO-220F15**

**> Maximum Ratings and Characteristics**

 - Absolute Maximum Ratings ( $T_C=25^\circ C$ ), unless otherwise specified

Item	Symbol	Rating	Unit
Drain-Source-Voltage	$V_{DS}$	500	V
Continous Drain Current	$I_D$	10	A
Pulsed Drain Current	$I_{D(puls)}$	40	A
Gate-Source-Voltage	$V_{GS}$	$\pm 30$	V
Repetitive or Non-Repetitive ( $T_{ch} \leq 150^\circ C$ )	$I_{AR}$	10	A
Avalanche Energy	$E_{AS}$	77,6	mJ
Max. Power Dissipation	$P_D$	50	W
Operating and Storage Temperature Range	$T_{ch}$	150	$^\circ C$
	$T_{stg}$	-55 ~ +150	$^\circ C$

 - Electrical Characteristics ( $T_C=25^\circ C$ ), unless otherwise specified

Item	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Drain-Source Breakdown-Voltage	$V_{(BR)DSS}$	$I_D=1mA$ $V_{GS}=0V$	500			V
Gate Threshold Voltage	$V_{GS(th)}$	$I_D=1mA$ $V_{DS}=V_{GS}$	3,5	4,0	4,5	V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS}=500V$ $T_{ch}=25^\circ C$ $V_{GS}=0V$ $T_{ch}=125^\circ C$		10	500	$\mu A$
Gate Source Leakage Current	$I_{GSS}$	$V_{GS}=\pm 30V$ $V_{DS}=0V$		10	100	nA
Drain Source On-State Resistance	$R_{DS(on)}$	$I_D=5A$ $V_{GS}=10V$		0,73	0,90	$\Omega$
Forward Transconductance	$g_{fs}$	$I_D=5A$ $V_{DS}=25V$	2,5	5		S
Input Capacitance	$C_{iss}$	$V_{DS}=25V$ $V_{GS}=0V$ $f=1MHz$		950	1450	pF
Output Capacitance	$C_{oss}$			180	270	pF
Reverse Transfer Capacitance	$C_{rss}$			80	120	pF
Turn-On-Time $t_{on}$ ( $t_{on}=t_{d(on)}+t_r$ )	$t_{d(on)}$	$V_{CC}=300V$ $I_D=10A$		25	40	ns
	$t_r$			70	110	ns
Turn-Off-Time $t_{off}$ ( $t_{off}=t_{d(off)}+t_f$ )	$t_{d(off)}$			70	110	ns
	$t_f$	$V_{GS}=10V$ $R_{GS}=10 \Omega$		45	70	ns
Avalanche Capability	$I_{AV}$		10			A
Diode Forward On-Voltage	$V_{SD}$	$I_F=2xI_{DR}$ $V_{GS}=0V$ $T_{ch}=25^\circ C$		1,1	1,65	V
Reverse Recovery Time	$t_{rr}$	$I_F=I_{DR}$ $V_{GS}=0V$		450		ns
Reverse Recovery Charge	$Q_{rr}$	$-dI_F/dt=100A/\mu s$ $T_{ch}=25^\circ C$		5,5		$\mu C$

**> Thermal Characteristics**

Item	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Thermal Resistance	$R_{th(ch-a)}$	channel to air			62,5	$^\circ C/W$
	$R_{th(ch-c)}$	channel to case			2,5	$^\circ C/W$

N-channel MOS-FET

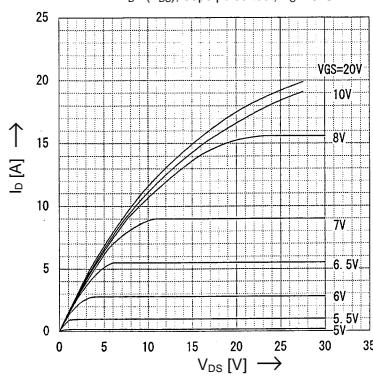
500V 0,9Ω 10A 50W

**2SK2640-01MR**  
FAP-II Series

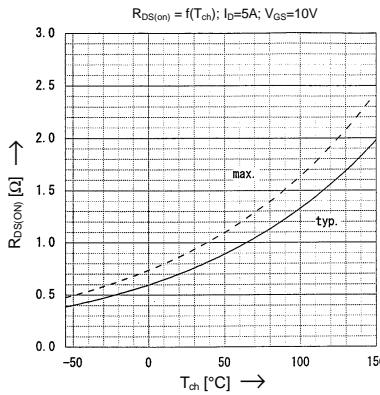
**FUJI**  
ELECTRIC

## > Characteristics

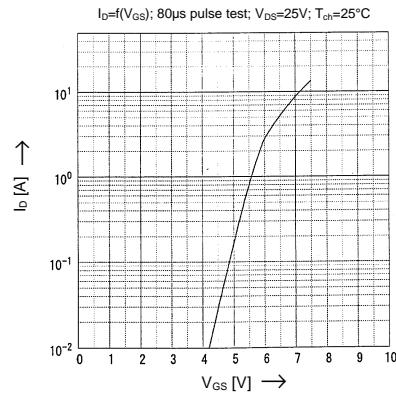
Typical Output Characteristics  
 $I_D=f(V_{DS})$ ; 80μs pulse test;  $T_C=25^\circ C$



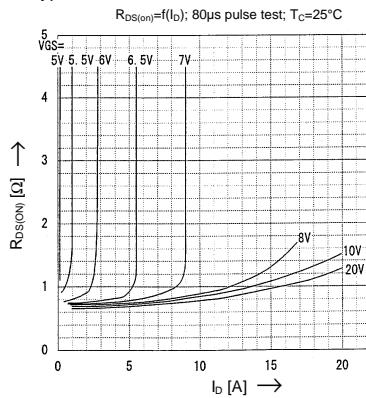
Drain-Source On-State Resistance vs.  $T_{ch}$



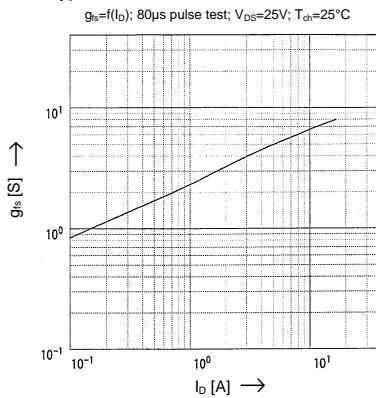
Typical Transfer Characteristics



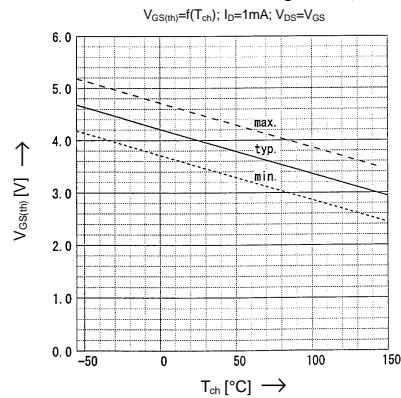
Typical Drain-Source On-State-Resistance vs.  $I_D$



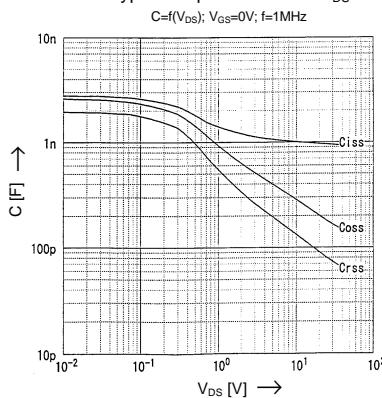
Typical Forward Transconductance vs.  $I_D$



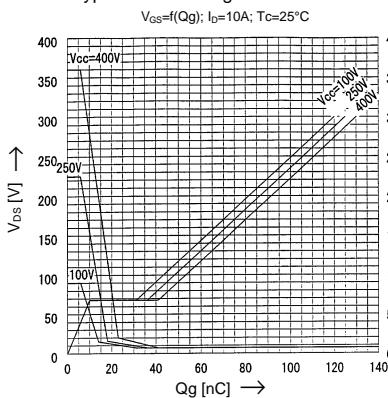
Gate Threshold Voltage vs.  $T_{ch}$



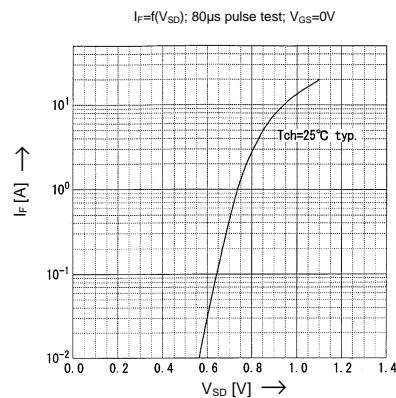
Typical Capacitances vs.  $V_{DS}$



Typical Gate Charge Characteristic

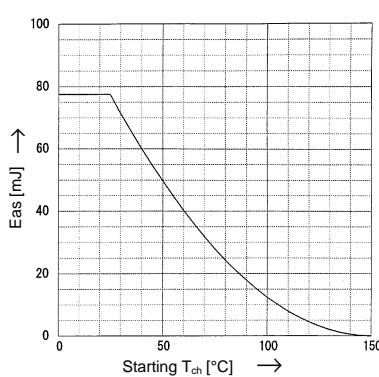


Forward Characteristics of Reverse Diode



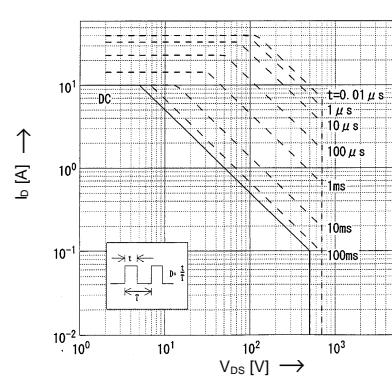
Avalanche Energy Derating

$E_{as}=f(\text{starting } T_{ch})$ ;  $V_{CC}=50V$ ;  $I_{AV}=10A$



Safe Operation Area

$I_D=f(V_{DS})$ ;  $D=0.01$ ,  $T_C=25^\circ C$



Transient Thermal impedance

